IGBT - Field Stop, Trench

650 V, 40 A

FGB40T65SPD-F085

General Description

Using the novel field stop 3rd generation IGBT technology, FGH40T65SPD-F085 offers the optimum performance with both low conduction loss and switching loss for a high efficiency operation in various applications, while provides 50 V higher blocking voltage and rugged high current switching reliability. Meanwhile, this part also offers and advantage of outstanding performance in parallel operation.

Features

- Low Saturation Voltage: $V_{CE(sat)} = 2.0 \text{ V} (Typ.) @ I_C = 40 \text{ A}$
- 100% of the Parts are Dynamically Tested *
- Short Circuit Ruggedness > 5 μs @ 25°C
- Maximum Junction Temperature : $T_J = 175^{\circ}C$
- Fast Switching
- Tight Parameter Distribution
- Positive Temperature Coefficient for Easy Parallel Operation
- Copacked with Soft, Fast Recovery Diode
- AEC-Q101 Qualified and PPAP Capable
- This Device is Pb-Free and are RoHS Compliant
- * V_{CC} = 400 V, V_{GE} = 15 V, I_C = 120 A, R_G = 20 Ω , Inductive Load

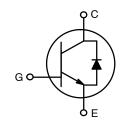
Applications

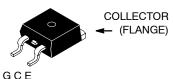
- Onboard Charger
- AirCon Compressor
- PTC Heater
- Motor Drivers
- Other Automotive Power-train and Auxiliary Applications



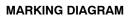
ON Semiconductor®

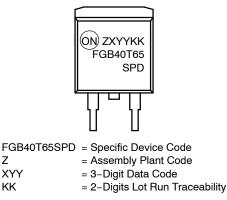
www.onsemi.com





D²PAK-3 (TO-263, 3-LEAD) CASE 418AJ





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ORDERING INFORMATION

See detailed ordering and shipping information on page 8 of this data sheet.

ABSOLUTE MAXIMUM RATINGS

| Symbol | Description | Ratings | Unit |
|------------------|---|-------------|------|
| V_{CES} | Collector to Emitter Voltage | 650 | V |
| V_{GES} | Gate to Emitter Voltage | ±20 | V |
| | Transient Gate to Emitter Voltage | ±30 | V |
| Ι _C | Collector Current (@ $T_C = 25^{\circ}C$ | 80 | А |
| | Collector Current $@ T_C = 100^{\circ}C$ | 40 | А |
| I _{CM} | Pulsed Collector Current (Note 1) | 120 | А |
| ١ _F | Diode Forward Current $@T_{C} = 25^{\circ}C$ | 40 | А |
| | Diode Forward Current $@ T_C = 100^{\circ}C$ | 20 | А |
| I _{FM} | Pulsed Diode Maximum Forward Current (Note 1) | 120 | А |
| PD | Maximum Power Dissipation $@T_{C} = 25^{\circ}C$ | 267 | W |
| | Maximum Power Dissipation @ T _C = 100°C | 134 | W |
| SCWT | Short Circuit Withstand Time $@T_{C} = 25^{\circ}C$ | 5 | μs |
| TJ | Operating Junction Temperature | –55 to +175 | °C |
| T _{stg} | Storage Temperature Range | –55 to +175 | °C |
| TL | Maximum Lead Temp. for soldering Purposes, 1/8" from case for 5 seconds | 300 | °C |

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected. 1. Repetitive rating: pulse width limited by max. junction temperature

ELECTRICAL CHARACTERISTICS OF THE IGBT ($T_C = 25^{\circ}C$ unless otherwise noted)

| Symbol | Parameter | Test Condition | Min | Тур | Max | Unit |
|--|---|---|-----|------|------|------|
| OFF CHARA | ACTERISTICS | - | | | | - |
| BV _{CES} | Collector to Emitter Breakdown Voltage | $V_{GE} = 0 V$, $I_C = 1 mA$ | 650 | - | - | V |
| $\frac{\Delta \text{BV}_{\text{CES}}}{\Delta \text{T}_{\text{J}}}$ | Temperature Coefficient of Breakdown Voltage | V _{GE} = 0 V, I _C = 1 mA | - | 0.6 | - | V/°C |
| I _{CES} | Collector Cut-Off Current | $V_{CE} = V_{CES}, V_{GE} = 0 V$ | - | - | 250 | μA |
| I _{GES} | G-E Leakage Current | $V_{GE} = V_{GES}, V_{CE} = 0 V$ | - | - | ±400 | nA |
| ON CHARA | CTERISTICS | • | | | | |
| V _{GE(th)} | G-E Threshold Voltage | I_{C} = 40 mA, V_{CE} = V_{GE} | 4.0 | 5.8 | 7.5 | V |
| V _{CE(sat)} | Collector to Emitter Saturation Voltage | I _C = 40 A, V _{GE} = 15 V | - | 2.0 | 2.4 | V |
| | | I_{C} = 40 A, V_{GE} = 15 V, T_{C} = 175°C | - | 2.9 | - | V |
| YNAMIC C | HARACTERISTICS | - | | | | |
| Cies | Input Capacitance | $V_{CE} = 30 V_{,} V_{GE} = 0 V_{,} f = 1 MHz$ | - | 1520 | - | pF |
| Coes | Output Capacitance | 7 | - | 92 | - | pF |
| C _{res} | Reverse Transfer Capacitance | | - | 15 | - | pF |
| WITCHING | CHARACTERISTICS | - | | | | |
| T _{d(on)} | Turn-On Delay Time | $V_{CC} = 400 \text{ V}, \text{ I}_{C} = 40 \text{ A}, \text{ R}_{G} = 6 \Omega,$ | - | 18 | - | ns |
| T _r | Rise Time | V _{GE} = 15 V, Inductive Load, T _C = 25°C | - | 26 | - | ns |
| T _{d(off)} | Turn-Off Delay Time | 1 | - | 35 | - | ns |
| Τ _f | Fall Time | 1 | - | 10 | - | ns |
| Eon | Turn-On Switching Loss | 1 | - | 0.97 | - | mJ |
| E _{off} | Turn-Off Switching Loss | 1 | - | 0.28 | - | mJ |
| E _{ts} | Total Switching Loss | 1 | _ | 1.25 | - | mJ |

ELECTRICAL CHARACTERISTICS OF THE IGBT (T_C = 25°C unless otherwise noted) (continued)

| Symbol | Parameter | Test Condition | Min | Тур | Max | Unit |
|---------------------|------------------------------|---|-----|------|-----|------|
| SWITCHING | CHARACTERISTICS | | | | | |
| T _{d(on)} | Turn-On Delay Time | $V_{CC} = 400 \text{ V}, \text{ I}_{C} = 40 \text{ A}, \text{ R}_{G} = 6 \Omega,$ | - | 14 | - | ns |
| T _r | Rise Time | V _{GE} = 15 V, Inductive Load, T _C = 175°C | - | 35 | - | ns |
| T _{d(off)} | Turn-Off Delay Time | | - | 38 | - | ns |
| Τ _f | Fall Time | | - | 13 | - | ns |
| E _{on} | Turn–On Switching Loss | | - | 1.61 | - | mJ |
| E _{off} | Turn-Off Switching Loss | | - | 0.47 | - | mJ |
| E _{ts} | Total Switching Loss | | - | 2.08 | - | mJ |
| T _{SC} | Short Circuit Withstand Time | V_{CC} = 400 V, V_{GE} = 15 V, R_{G} = 10 Ω | 5 | - | - | μs |
| Qg | Total Gate Charge | V_{CE} = 400 V, I _C = 40 A, V _{GE} = 15 V | - | 36 | - | nC |
| Q _{ge} | Gate to Emitter Charge | | - | 12 | - | nC |
| Q _{gc} | Gate to Collector Charge | | - | 11 | - | nC |

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

ELECTRICAL CHARACTERISTICS OF THE DIODE ($T_C = 25^{\circ}C$ unless otherwise noted)

| Symbol | Parameter | Test Condition | | Min | Тур | Max | Unit |
|------------------|-------------------------------|--------------------------------|------------------------|-----|-----|-----|------|
| V _{FM} | Diode Forward Voltage | I _F = 20 A | $T_C = 25^{\circ}C$ | - | 2.0 | 2.7 | V |
| | | | $T_C = 175^{\circ}C$ | - | 1.8 | - | |
| E _{rec} | Reverse Recovery Energy | $I_{\rm F} = 20 {\rm A},$ | T _C = 175°C | - | 51 | - | μJ |
| T _{rr} | Diode Reverse Recovery Time | dl _F /dt = 200 A/μs | $T_C = 25^{\circ}C$ | - | 34 | - | ns |
| | | | $T_C = 175^{\circ}C$ | - | 206 | - | |
| Q _{rr} | Diode Reverse Recovery Charge | 1 | $T_C = 25^{\circ}C$ | - | 56 | - | nC |
| | | | $T_C = 175^{\circ}C$ | - | 731 | - | |

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

THERMAL CHARACTERISTICS

| Symbol | Parameter | Тур | Max | Unit |
|-------------------------|---|-----|------|------|
| $R_{\theta JC}(IGBT)$ | Thermal Resistance, Junction to Case | - | 0.56 | °C/W |
| $R_{\theta JC}$ (Diode) | Thermal Resistance, Junction to Case | - | 1.71 | °C/W |
| $R_{\theta JA}$ | Thermal Resistance, Junction to Ambient | - | 40 | °C/W |

TYPICAL PERFORMANCE CHARACTERISTICS

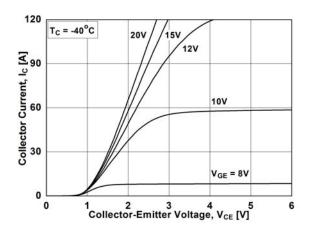


Figure 1. Typical Output Characteristics

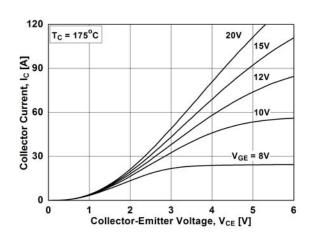


Figure 3. Typical Output Characteristics

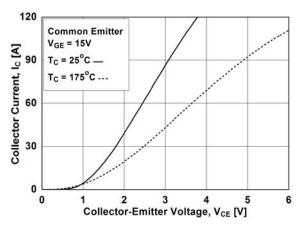
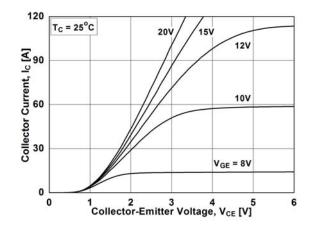
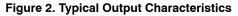
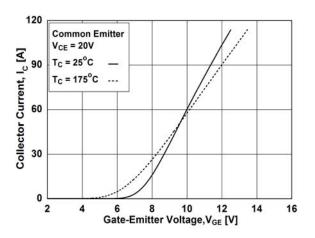


Figure 5. Typical Saturation Voltage









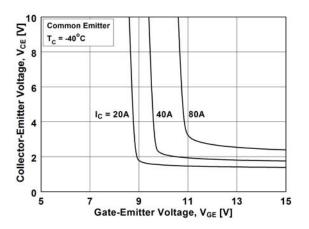
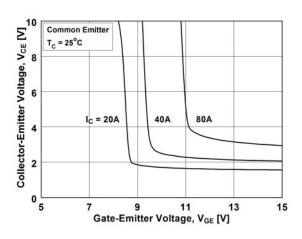


Figure 6. Saturation Voltage vs. V_{GE} Characteristics

TYPICAL PERFORMANCE CHARACTERISTICS (continued)





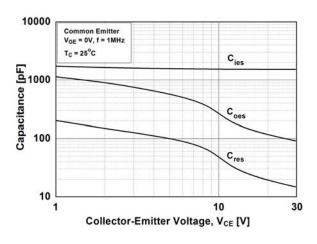


Figure 9. Capacitance Characteristics

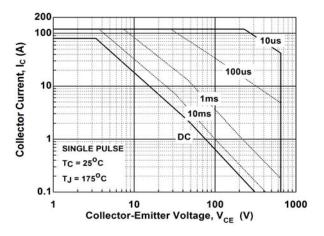
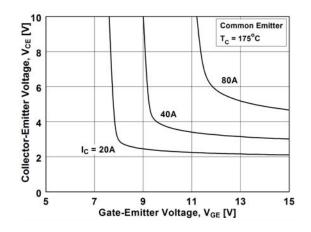
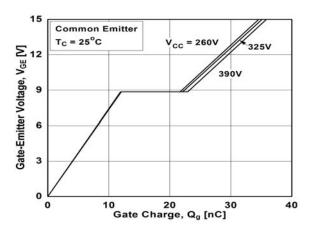


Figure 11. SOA Characteristics









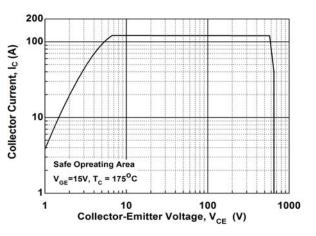
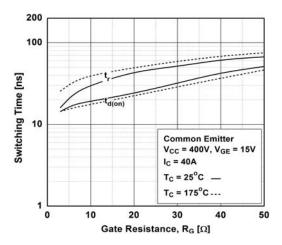


Figure 12. Turn Off Switching SOA Characteristics

TYPICAL PERFORMANCE CHARACTERISTICS (continued)





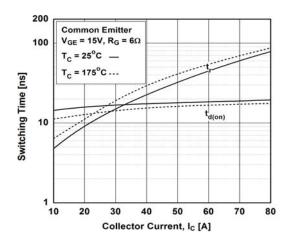


Figure 15. Turn-on Characteristics vs. Collector Current

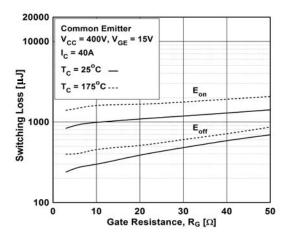


Figure 17. Switching Loss vs. Gate Resistance

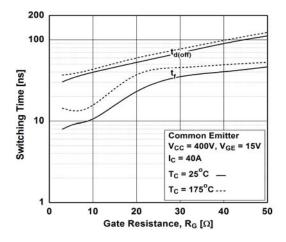


Figure 14. Turn-off Characteristics vs. Gate Resistance

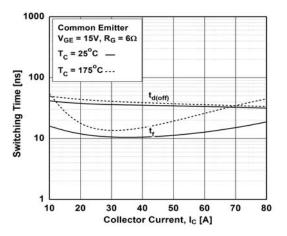


Figure 16. Turn-off Characteristics vs. Collector Current

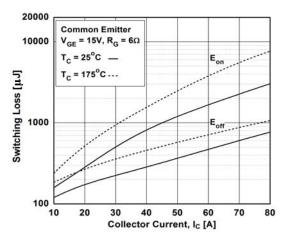


Figure 18. Switching Loss vs. Collector Current

TYPICAL PERFORMANCE CHARACTERISTICS (continued)

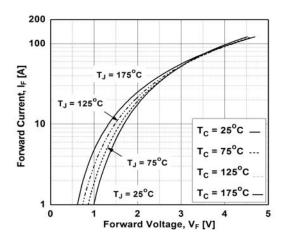


Figure 19. Forward Characteristics

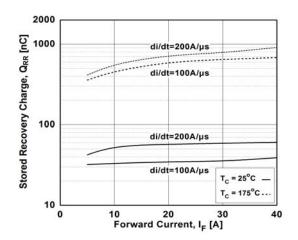


Figure 21. Stored Charge

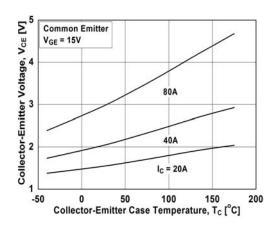


Figure 23. Saturation Voltage vs. Case Temperature at Variant Current Level

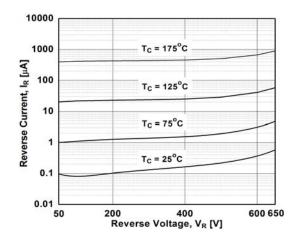


Figure 20. Reverse Current

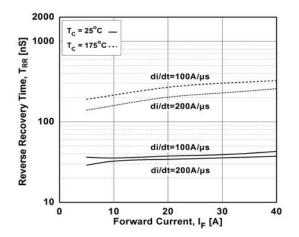


Figure 22. Reverse Recovery Time

TYPICAL PERFORMANCE CHARACTERISTICS (continued)

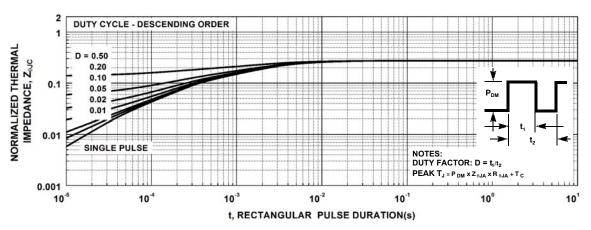


Figure 24. Transient Thermal Impedance of IGBT

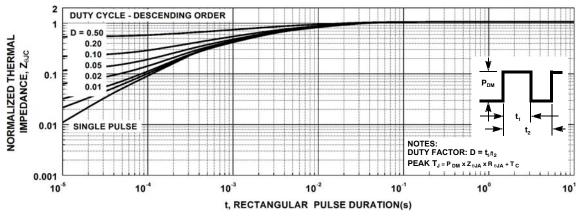


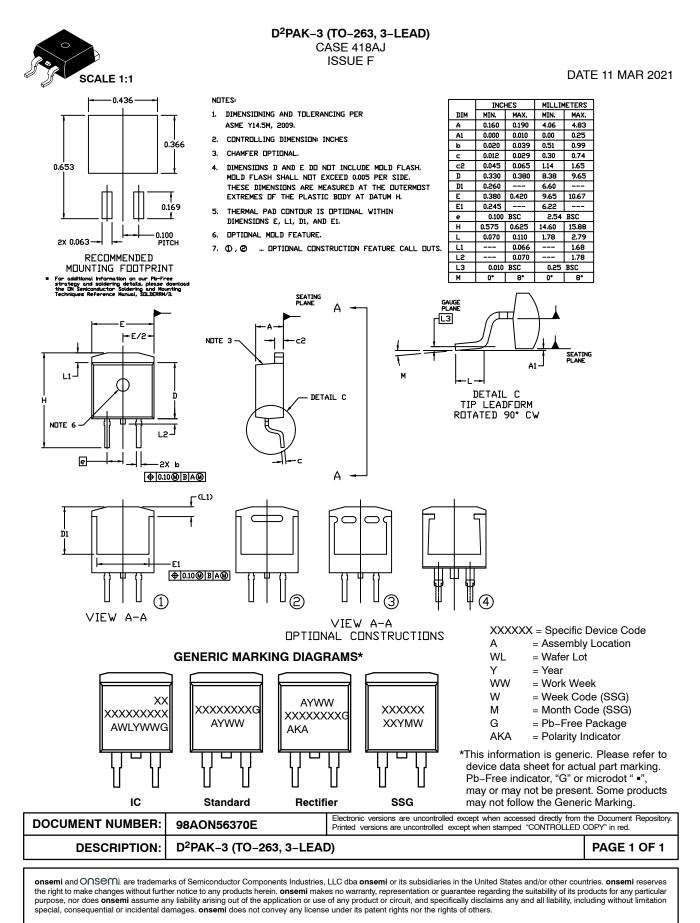
Figure 25. Transient Thermal Impedance of Diode

PACKAGE MARKING AND ORDERING INFORMATION

| Device Marking | Device | Package | Reel Size | Tape Width | Shipping [†] |
|----------------|------------------|--|-----------|------------|-----------------------|
| FGB40T65SPD | FGB40T65SPD-F085 | D ² PAK–3 (TO–263, 3–LEAD) (Pb–Free) | - | - | 800 / Tape & Reel |

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.





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